

Search Notes

Application/Control No.

10/825,416

Examiner

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Applicant(s)/Patent under
Reexamination

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Art Unit

2871

SEARCHED

Class	Subclass	Date	Examiner
349	146,141, 129	7/26/2005	JAD

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
PGPub	above	7/26/2005	(J)

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR